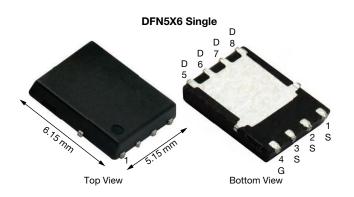


RoHS

COMPLIANT

AM7432N-T1-PF-VB Datasheet N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^{a, e}	Q _g (Typ)			
30	0.007 at V _{GS} = 10 V	80	31 nC			
30	0.009 at V _{GS} = 4.5 V	60	51110			

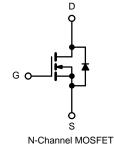


FEATURES

- TrenchFET[®] Power MOSFET
- •
- 100 % R_g and UIS Tested Compliant to RoHS Directive 2011/65/EU ٠

APPLICATIONS

- OR-ing
- Server DC/DC



Parameter		Symbol	Limit		Unit	
Drain-Source Voltage		V _{DS}	30			
Gate-Source Voltage		V _{GS}	±	20	V	
	T _C = 25 °C		80		- A	
Continuous Drain Current (T _J = 175 °C)	T _C = 70 °C	1	60			
	T _A = 25 °C	I _D	50b, c			
	T _A = 70 °C		45 ^{b, c}			
Pulsed Drain Current		I _{DM} 210		0		
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	60			
Single Pulse Avalanche Energy		E _{AS}	95		mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	80		- A	
Continuous Source-Drain Diode Current	T _A = 25 °C	'S	60			
Maximum Power Dissipation	T _C = 25 °C	D	155		10/	
	T _C = 70 °C	PD	105		W	
Operating Junction and Storage Temperature Rang	e	T _J , T _{stg}	- 55 to 175		°C	
THERMAL RESISTANCE RATINGS	5					
Parameter		Symbol	Тур.	Max.	Unit	
Maximum Junction-to-Ambient ^{b, d}	$t \le 10 \text{ sec}$	R _{thJA}	32	40	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	0.5 0.6			

Notes:

a. Based on T_C = 25 °C. b. Surface mounted on 1" x 1" FR4 board.

- c. t = 10 sec.
- d. Maximum under steady state conditions is 90 °C/W.
 e. Calculated based on maximum junction temperature. Package limitation current is 90 A.

SPECIFICATIONS (T_J = 25 °C, unless otherwise noted)								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Static	•				•			
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_{D} = 250 \mu A$	30			V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 µA		35		mV/°C		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	- 7.5	- 7.5				
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	0.5		2.0	V		
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA		
Zero Gate Voltage Drain Current		$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	μA		
	IDSS	V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			10			
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	90			А		
		V _{GS} = 10 V, I _D = 30.8 A		0.007		Ω		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 27 A		0.009				
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 30.8 A		160		S		
Dynamic ^b					1	1		
Input Capacitance	C _{iss}				1180			
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz			425	pF		
Reverse Transfer Capacitance	C _{rss}				170			
T + 0 + 0	Qg	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 30.8 A			61	nC		
Total Gate Charge					31.5			
Gate-Source Charge	Q _{gs}	V_{DS} = 15 V, V_{GS} = 4.5 V, I_{D} = 27.8 A			10			
Gate-Drain Charge	Q _{gd}				6			
Gate Resistance	Rg	f = 1 MHz		1.4	2.1	Ω		
Turn-On Delay Time	t _{d(on)}			18	27	ns		
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.625 Ω		11	17			
Turn-Off Delay Time	t _{d(off)}	$\text{I}_{\text{D}}\cong$ 24 A, V_{GEN} = 10 V, R_{g} = 1 Ω		70	105			
Fall Time	t _f			10	15			
Turn-On Delay Time	t _{d(on)}			55	83			
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.67 Ω		180	270			
Turn-Off Delay Time	t _{d(off)}	${ m I_D}\cong$ 22.5 A, ${ m V_{GEN}}$ = 4.5 V, ${ m R_g}$ = 1 Ω		55	83			
Fall Time	t _f			12	18			
Drain-Source Body Diode Characteristic	s				•			
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C		60		A		
Pulse Diode Forward Current ^a	I _{SM}			210				
Body Diode Voltage	V _{SD}	I _S = 22 A	I _S = 22 A		1.2	V		
Body Diode Reverse Recovery Time	t _{rr}			52	78	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			70.2	105	nC		
Reverse Recovery Fall Time	t _a	I _F = 20 A, di/dt = 100 A/μs, T _J = 25 °C		27		1		
Reverse Recovery Rise Time		t _b		25		ns		

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

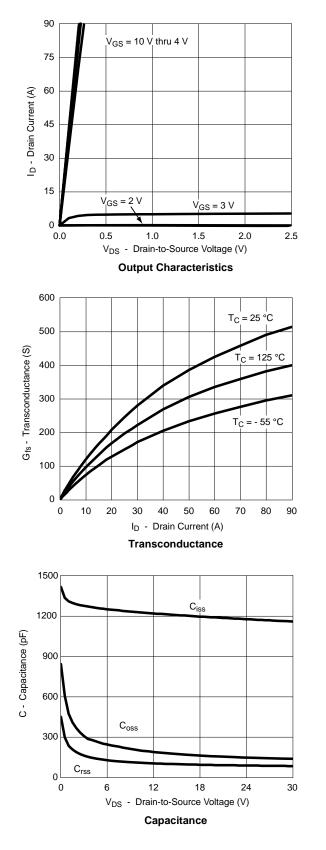
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

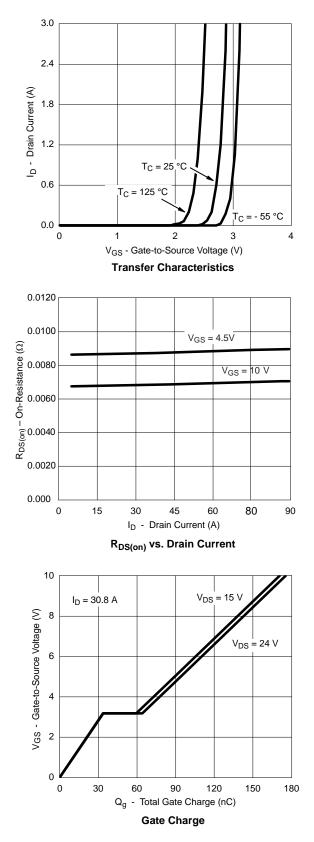
semi

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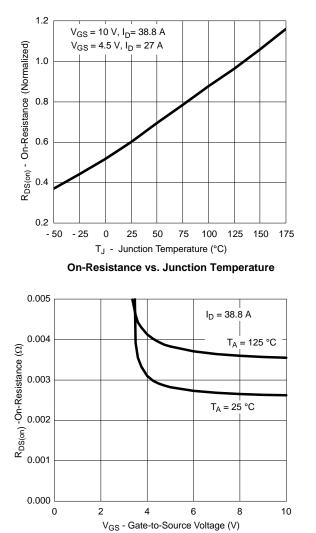
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



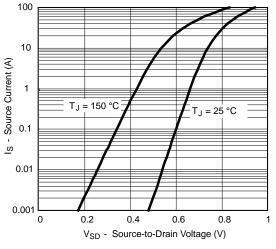




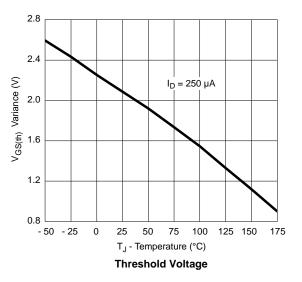
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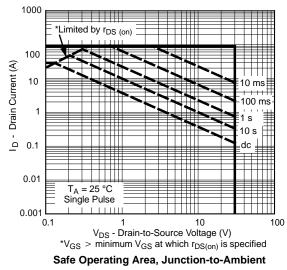


R_{DS(on)} vs. V_{GS} vs. Temperature

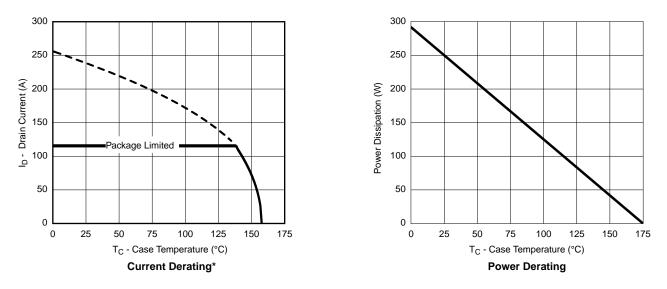


Forward Diode Voltage vs. Temperature



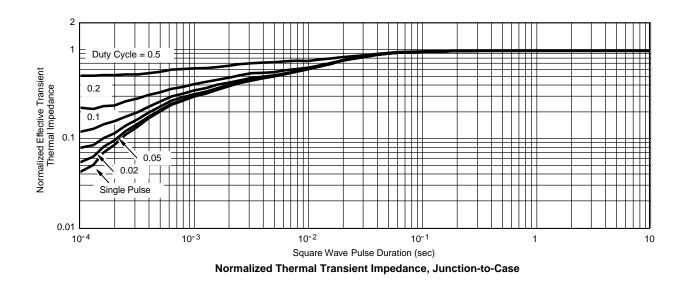






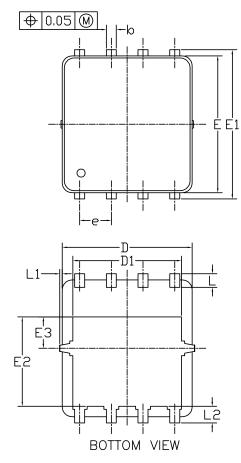
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

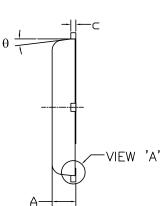
*The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

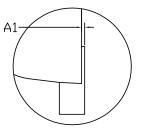






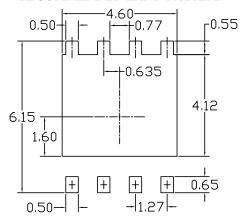






<u>VIEW 'A'</u> (SCALE 5:1)

RECOMMENDED LAND PATTERN



SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
SIMBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
А	0.85	0.95	1.00	0.033	0.037	0.039	
A1	0.00		0.05	0.000		0.002	
b	0.30	0.40	0.50	0.012	0.016	0.020	
c	0.15	0.20	0.25	0.006	0.008	0.010	
D	5.10	5.20	5.30	0.201	0.205	0.209	
D1	4.25	4.35	4.45	0.167	0.171	0.175	
Е	5.45	5.55	5.65	0.215	0.219	0.222	
E1	5.95	6.05	6.15	0.234	0.238	0.242	
E2	3.525	3.625	3.725	0.139	0.143	0.147	
E3	1.175	1.275	1.375	0.046	0.050	0.054	
e	1.27 BSC		0.050 BSC				
L	0.45	0.55	0.65	0.018	0.022	0.026	
L1	0		0.15	0		0.006	
L2	0.68 REF		0.027 REF				
θ	0°		10°	0°		10°	

NOTE

1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.

MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.

2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

UNIT: mm



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